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Application/Control No.	Applicant(s)/Patent under Reexamination
10/724,006	ERCHAK ET AL
Examiner	Art Unit
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SEARCHED				
Class	Subclass	Date	Examiner	
257	79,98 100,103	2/10/2005	O.N.	
438	22-27,29	2/10/2005	O.N.	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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